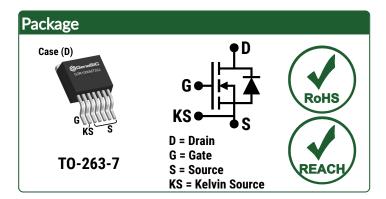


#### Silicon Carbide MOSFET N-Channel Enhancement Mode

 $\begin{array}{lll} V_{DS} & = & 3300 \ V \\ R_{DS(ON)(Typ.)} & = & 1000 \ m\Omega \\ I_{D} \ (T_{C} = 100^{\circ}C) & = & 4 \ A \end{array}$ 

#### **Features**

- G2R<sup>™</sup> SiC MOSFET Technology
- Superior Q<sub>G</sub> x R<sub>DS(ON)</sub> Figure of Merit
- Low Capacitances and Low Gate Charge
- Normally-Off Stable Operation up to 175°C
- Fast and Reliable Body Diode
- High Avalanche and Short Circuit Ruggedness
- Low Conduction Losses at High Temperatures
- Optimized Package with Separate Driver Source Pin



### **Advantages**

- Increased Power Density for Compact System
- High Frequency Switching
- Reduced Losses for Higher System Efficiency
- Minimized Gate Ringing
- Improved Thermal Capabilities
- High Cost-Performance Index
- Ease of Paralleing without Thermal Runaway
- Simple to Drive

### **Applications**

- Auxiliary Power Supply
- Switched Mode Power Supply
- High Voltage Converters
- Pulsed Power

Absolute Maximum Ratings (At T <sub>C</sub> = 25°C Unless Otherwise Stated)								
Parameter	Symbol	Conditions	Values	Unit	Note			
Drain-Source Voltage	$V_{DS(max)}$	$V_{GS}$ = 0 V, $I_D$ = 100 $\mu$ s	3300	V				
Gate-Source Voltage (Dynamic)	V <sub>GS(max)</sub>		-10 / +25	٧				
Gate-Source Voltage (Static)	V <sub>GS(op)</sub>	Recommended Operation	-5 / +20	٧				
Continuous Forward Current	l <sub>a</sub>	$T_C = 100$ °C, $V_{GS} = 20 \text{ V}$	4	Λ	Fig. 15			
	I <sub>D</sub>	$T_C = 135^{\circ}C$ , $V_{GS} = 20 \text{ V}$	3	Α				
Pulsed Drain Current	$I_{D(pulse)}$	$t_P \le 10\mu s$ , D ≤ 1%, Note 1	8	Α	Fig. 14			
Power Dissipation	$P_D$	T <sub>c</sub> = 25°C	74	W	Fig. 16			
Operating and Storage Temperature	$T_j$ , $T_{stg}$		-55 to 175	°C				

Thermal/Package Characteristics							
Doromotor	Symbol	Conditions		Values		— Unit	Note
Parameter	Зушьог	Conditions	Min.	Тур.	Max.		
Thermal Resistance, Junction - Case	$R_{thJC}$			2.03		°C/W	Fig. 13
Weight	W <sub>T</sub>			1.45		g	

Note 1: Pulse Width  $t_P$  Limited by  $T_{j(max)}$ 



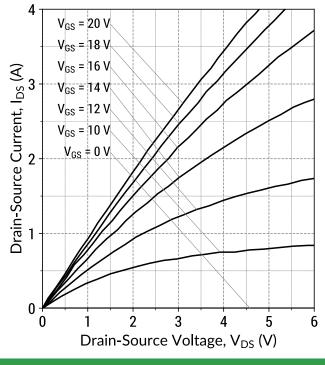


#### Electrical Characteristics (At T<sub>C</sub> = 25°C Unless Otherwise Stated) **Values** Parameter **Symbol Conditions** Unit Note Min. Max. Typ. $V_{GS} = 0 \text{ V, } I_{D} = 100 \mu\text{A}$ ٧ **Drain-Source Breakdown Voltage** $\nu_{\text{\tiny DSS}}$ 3300 Zero Gate Voltage Drain Current $V_{DS} = 3300 \text{ V, } V_{GS} = 0 \text{ V}$ 1 μΑ IDSS $V_{DS} = 0 V, V_{GS} = 25 V$ 100 **Gate Source Leakage Current** nΑ $I_{\text{GSS}}$ $V_{DS} = 0 V, V_{GS} = -10 V$ -100 $V_{DS} = V_{GS}$ , $I_D = 2 \text{ mA}$ 2.8 3.5 Gate Threshold Voltage $V_{GS(th)}$ ٧ Fig. 9 $V_{DS} = V_{GS}$ , $I_{D} = 2$ mA, $T_{j} = 175$ °C 2.4 $V_{DS} = 10 \text{ V, } I_{D} = 2 \text{ A}$ 0.75 S Transconductance Fig. 4 $g_{\text{fs}} \\$ $V_{DS} = 10 \text{ V, } I_D = 2 \text{ A, } T_j = 175 ^{\circ}\text{C}$ 0.5 $V_{GS} = 20 \text{ V, } I_D = 2 \text{ A}$ 1000 1200 Drain-Source On-State Resistance $m\Omega$ Fig. 5-8 R<sub>DS(ON)</sub> $V_{GS} = 20 \text{ V, } I_D = 2 \text{ A, } T_i = 175^{\circ}\text{C}$ 2500 Input Capacitance $C_{\text{iss}}$ 238 **Output Capacitance** $C_{oss}$ 10 pF Fig. 11 $V_{DS} = 1000 \text{ V, } V_{GS} = 0 \text{ V}$ **Reverse Transfer Capacitance** 2.4 $C_{rss}$ f = 1 MHz, $V_{AC} = 25mV$ Coss Stored Energy $E_{oss} \\$ 11 μJ Fig. 12 Coss Stored Charge 17 nC $Q_{\text{oss}}$ **Gate-Source Charge** 11 $Q_{gs}$ $V_{DS}$ = 1000 V, $V_{GS}$ = -5 / +20 V Gate-Drain Charge $Q_{qd}$ $I_D = 2 A$ 6 nC Fig. 10 Per IEC607478-4 **Total Gate Charge** 21 $Q_g$ Internal Gate Resistance $R_{G(int)}$ $f = 1 MHz, V_{AC} = 25 mV$ 5 Ω

Reverse Diode Characteristics							
Darameter	Symbol	Conditions	Values		Unit	Note	
Parameter		Colluitions	Min.	Тур.	Max.	UIIIL	Note
Diode Forward Voltage	$V_{\text{SD}}$	$V_{GS} = -5 \text{ V, } I_{SD} = 1 \text{ A}$		5		V	Fig.
		$V_{GS} = -5 \text{ V, } I_{SD} = 1 \text{ A, } T_j = 175^{\circ}\text{C}$	6		v	17-18	
Continuous Diode Forward Current	Is	$V_{GS} = -5 \text{ V, } T_c = 100 ^{\circ}\text{C}$		2		Α	
Diode Pulse Current	I <sub>S(pulse)</sub>	V <sub>GS</sub> = -5 V, Note 1		8		Α	

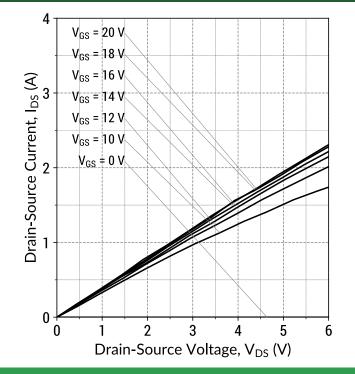


Figure 1: Output Characteristics (T<sub>j</sub> = 25°C)



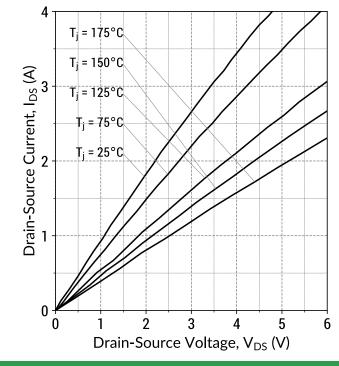
 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu s$ 

Figure 2: Output Characteristics (T<sub>i</sub> = 175°C)



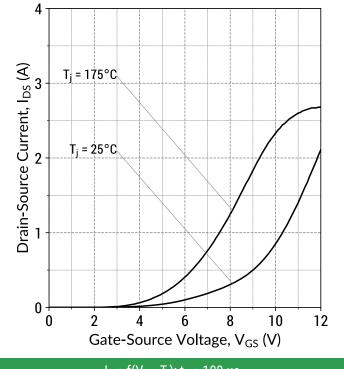
 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu s$ 

Figure 3: Output Characteristics (VGS = 20 V)



 $I_D = f(V_{DS}, T_j); t_P = 250 \mu s$ 

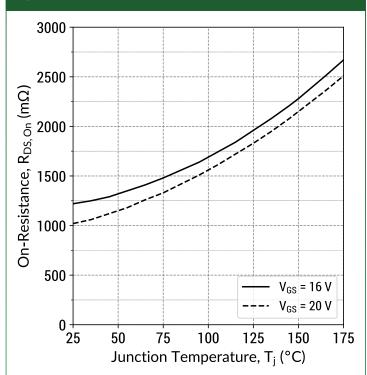
Figure 4: Transfer Characteristics (V<sub>DS</sub> = 10 V)



 $I_D = f(V_{GS}, T_j); t_P = 100 \ \mu s$ 

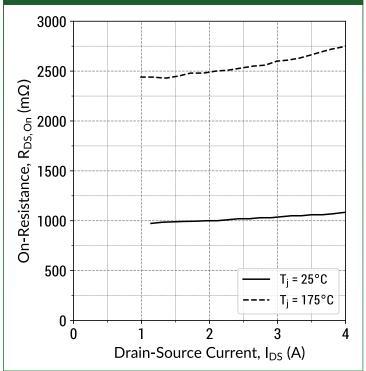






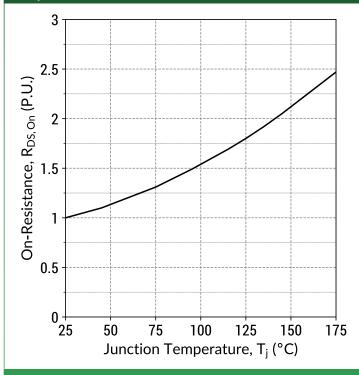
 $R_{DS(ON)} = f(T_i, V_{GS}); t_P = 250 \mu s; I_D = 2 A$ 

Figure 6: On-State Resistance v/s Drain Current



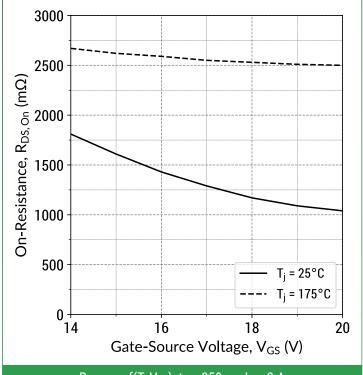
 $R_{DS(ON)} = f(T_j,I_D); t_P = 250 \mu s; V_{GS} = 20 V$ 

Figure 7: Normalized On-State Resistance v/s Temperature



 $R_{DS(ON)} = f(T_i)$ ;  $t_P = 250 \mu s$ ;  $I_D = 2 A$ ;  $V_{GS} = 20 V$ 

Figure 8: On-State Resistance v/s Gate Voltage

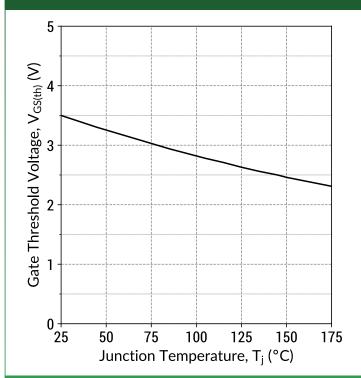


 $R_{DS(ON)}$  =  $f(T_j,V_{GS})$ ;  $t_P$  = 250  $\mu$ s;  $I_D$  = 2 A



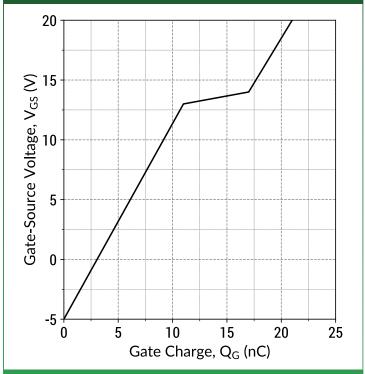






 $V_{GS(th)} = f(T_j)$ ;  $V_{DS} = V_{GS}$ ;  $I_D = 2 \text{ mA}$ 

Figure 10: Gate Charge Characteristics



 $I_D = 2 A$ ;  $V_{DS} = 1000 V$ ;  $T_c = 25$ °C

Figure 11: Capacitance v/s Drain-Source Voltage

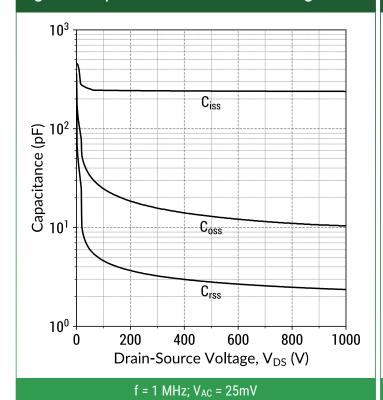


Figure 12: Output Capacitor Stored Energy

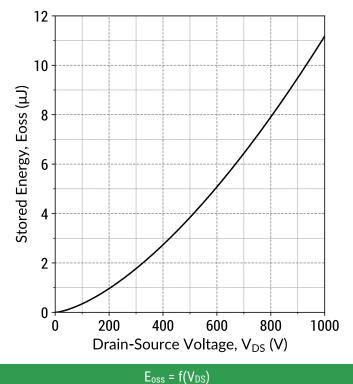
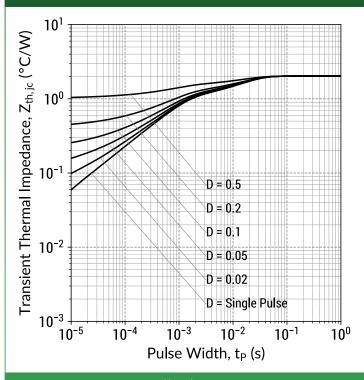


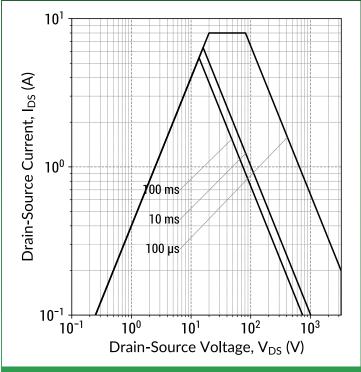


Figure 13: Transient Thermal Impedance



 $Z_{th,jc} = f(t_P,D); D = t_P/T$ 

Figure 14: Safe Operating Area (T<sub>c</sub> = 25°C)



 $I_D = f(V_{DS}, t_P); T_j \le 175^{\circ}C; D = 0$ 

Figure 15: Current De-rating Curve

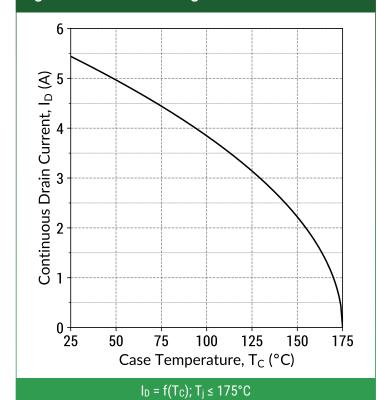


Figure 16: Power De-rating Curve

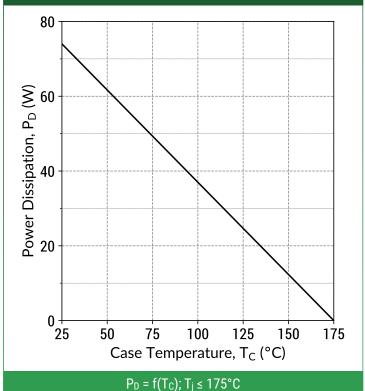
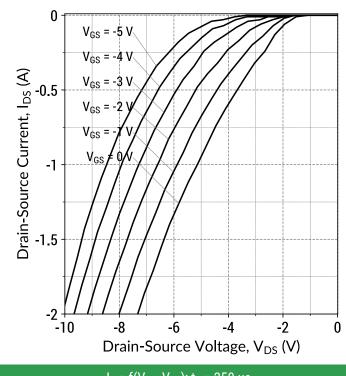


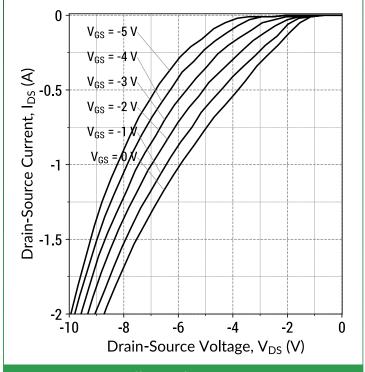


Figure 17: Body Diode Characteristics (T<sub>i</sub> = 25°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \ \mu s$ 

Figure 18: Body Diode Characteristics (T<sub>i</sub> = 175°C)



 $I_D = f(V_{DS}, V_{GS}); t_P = 250 \mu s$ 

Figure 19: Third Quadrant Characteristics (T<sub>i</sub> = 25°C)

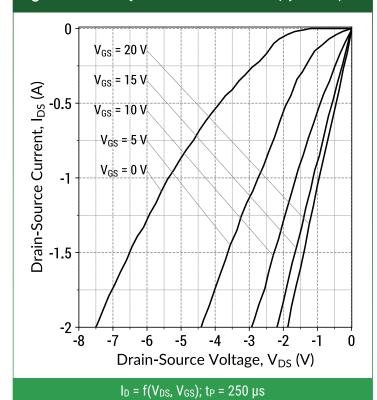
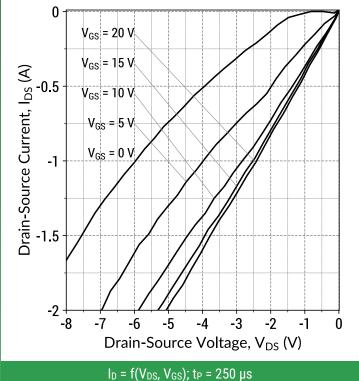
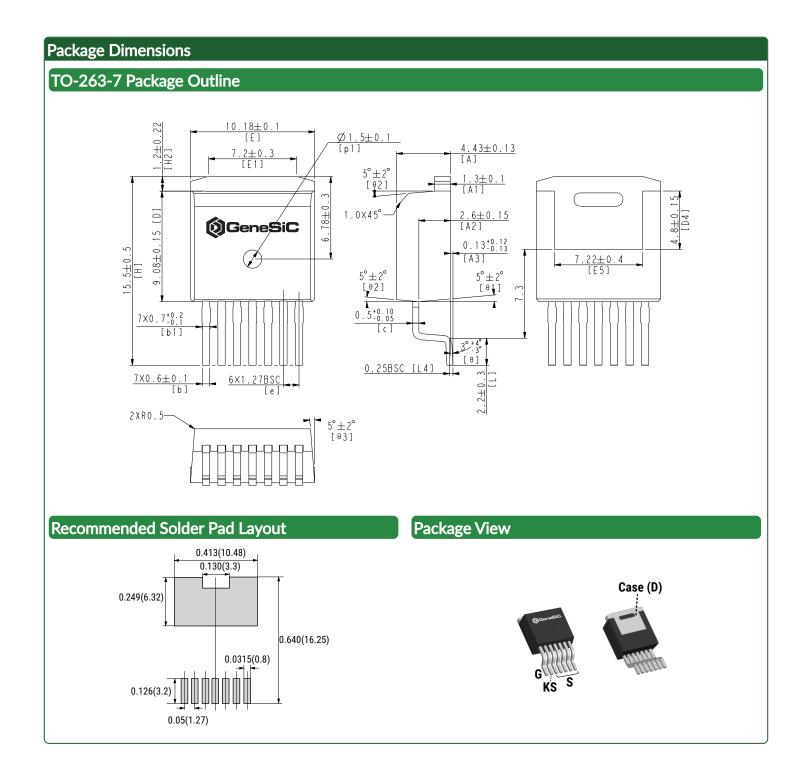


Figure 20: Third Quadrant Characteristics (T<sub>j</sub> = 175°C)







#### **NOTE**

- 1. CONTROLLED DIMENSION IS INCH. DIMENSION IN BRACKET IS MILLIMETER.
- 2. DIMENSIONS DO NOT INCLUDE END FLASH, MOLD FLASH, MATERIAL PROTRUSIONS.





### Compliance

#### **RoHS Compliance**

The levels of RoHS restricted materials in this product are below the maximum concentration values (also referred to as the threshold limits) permitted for such substances, or are used in an exempted application, in accordance with EU Directive 2011/65/EC (RoHS 2), as adopted by EU member states on January 2, 2013 and amended on March 31, 2015 by EU Directive 2015/863. RoHS Declarations for this product can be obtained from your GeneSiC representative.

#### **REACH Compliance**

REACH substances of high concern (SVHCs) information is available for this product. Since the European Chemical Agency (ECHA) has published notice of their intent to frequently revise the SVHC listing for the foreseeable future, please contact a GeneSiC representative to insure you get the most up-to-date REACH SVHC Declaration. REACH banned substance information (REACH Article 67) is also available upon request.

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#### **Revision History**

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Date	Revision	Comments	Supersedes
Aug. 3, 2020	Rev 1	Initial Release	



www.genesicsemi.com/sic-mosfet/

